

Search Notes 	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/669,377	CHAE ET AL.
	Examiner	Art Unit
	James A. Dudek	2871

Search Notes



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10/669,377

Examiner

James A. Dudek

**Applicant(s)/Patent under
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Art Unit

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INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)